



# UTAH NANO FAB Tool List



## Nano-scale EM Imaging & Surface Analysis

<https://emsal.nanofab.utah.edu/>

### ELECTRON MICROSCOPES

- ♦ STEM: JEOL JEM-2800 with ultrafast EDS (3D tomo) Protochips liq & gas phase ETEM / electrochemistry
- ♦ dbFIB: FEI Helios Nanolab 650i hi-res, Nabity EBL Pt, W, C dep; XeF<sub>2</sub>, I<sub>2</sub>, H<sub>2</sub>O enhanced etch, EDS, EBSD
- ♦ SEM: FEI Quanta 600 FE-ESEM w/ EDS, EBSD, particle ID, MAPS, Bruker PI-89 Picoindenter stage
- ♦ SEM: FEI Teneo FE-SEM w/ EDS, EBSD, Trinity™ imaging detectors
- ♦ SEM: JEOL IT200LV (W-filament SEM) – cleanroom inspection microscope

### MATERIALS CHARACTERIZATION: (COMPOSITION, STRUCTURE, MECHANICAL, OPTICAL, MAGNETIC, ELECTRICAL)

- ♦ **New!** – nanoCT: Zeiss Xradia 620 Versa 4D non-destructive imaging, 600nm resolution, in-situ (heating/cooling/tension/compression)
- ♦ **New!** – XRD (Hi-Res): Bruker Discover D8, thin film/powder/crystalline/polycrystalline samples, XRR, RSM, rocking curves,  $\theta/2\theta$ , 1100° heating stage
- ♦ **New!** Cathodoluminescence (CL) detector (Teneo SEM): Gatan Monarc Pro hyperspectral imaging
- ♦ **New!** LC-MS/MS: Agilent 6470B, m/z 5 – 3000, 0.7 Da resolution
- ♦ SAXS/WAXS/GISAXS: Anton Paar SAXSPoint 5.0 with in situ heating/cooling/mechanical loading/humidity
- ♦ DLS: Anton Paar Litesizer 500 with Zeta potential
- ♦ XRF: EDAX Eagle III Microspot ( $\mu$ probe & mapping)
- ♦ Nanoindenter: Hysitron TI Premier with heating stage
- ♦ Picoindenter: stage for SEM, Hysitron PI89
- ♦ Magnetometer: Microsense vibrating sample magnetometer (EZ-7 VSM)
- ♦ Potentiostat: Gamry Reference 600+

### SURFACE ANALYSIS

- ♦ XPS/AES/ISS/UPS: Kratos AxisUltra
- ♦ AFM: Bruker ICON-PT with PF-QNM, wet cell, MFM, KPFM
- ♦ Ellipsometer: Woollam V-VASE spectroscopic

### OPTICAL MICROSCOPES AND PROFILERS

- ♦ Olympus OLS5000 LEXT 3D measuring laser microscope
- ♦ Keyence VHX1 3D measuring microscope
- ♦ Vertex 220 microVu Digital Comparator
- ♦ Optical Microscope: Reichert MeF<sub>3</sub> with BF, DF, DIC

### SAMPLE PREPARATION (COATING, POLISHING, ION-POLISHING, PLASMA CLEANING)

- ♦ Micro fiducial laser cutter for correlative multiscale microscopy: 355, 532, 1064 nm; 1.2-15mJ
- ♦ Sample Coating for SEM imaging (Au/Pd, C, Cr): Gatan PECS I, Leica ACE600
- ♦ Mechanical polishing: SEM/TEM prep tool suite
- ♦ Ion polishing: Fischione 1060, Gatan PECS I and II
- ♦ Plasma Cleaner for TEM samples: Fischione 1020

## Cleanroom Micro and Nanofabrication

<https://www.nanofab.utah.edu/>

### LITHOGRAPHY (Class 100) *Pattern Generation & Direct Write*

- ♦ **Coming Soon!** Raith Voyager EBL electron beam lithography tool. 8nm min feature size. Chips to 200mm wafers. Stitch-free modes for arrays and vector writing.
- ♦ Nanoscribe Professional GT-2 micro/nano 3D printer: 200nm- $\mu$ m-mm scale printing on silicon and glass. IP-DIP, IP-S, IP-Q, IP-Visio, IP-PDMS, GP-Silica, IP-n162 Resins
- ♦ Heidelberg DWL66+ Laser Pattern Generator submicron 0.3 $\mu$ m (300nm) min lines and spaces, gray-scale patterning, direct write up to 200mm substrates and 9" photomasks.
- ♦ Heidelberg  $\mu$ PG 101 Laser Pattern Generator (x2) 0.9 $\mu$ m, 2.5 $\mu$ m write heads, gray scale lithography
- ♦ Nanofrazor 30nm-200nm nanolithography tool
- ♦ EVG EV-420, Suss MA1006 front & backside mask aligner
- ♦ OAI Models 200 & 810 (with BSA) contact aligners
- ♦ Spinners, ovens, hot plates, fume hoods, SRDs, ultrasonic lift-off. CEE Apogee spinner/bakeplate.
- ♦ LOR 10B, AZ 10XT, Shipley 1813, nLOF 2020, AZ 40XT, SU8, ma-P 1275, AZ Barlii II ARC, AZ MiR 701, HMDS
- ♦ L-Edit, Cadence, AutoCAD, SolidWorks
- ♦ Link-CAD DXF/GDSII/CIF/BMP conversion tools

### THIN FILM DEPOSITION (Class 1000)

#### *Sputtering:*

- ♦ TMV SS-40C: 8 dedicated cathodes, dual cryo-pumped
- ♦ Denton Discovery 18: 3 user config 3" cathodes, RF/DC/Reactive/Heated sputtering.



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- ♦ Denton 635LL: 4-cathodes, RGA, OES-feedback reactive O<sub>2</sub> or N<sub>2</sub> sputter, heated/cooled chuck to 500°C, co-sputtering, coats up to 200mm dia wafers

*Precious Metals:* Ag, Au, Ir, Pd, Pt, Ru

*Other Metals/Alloys:* Al, Al/Si, BN, C, Chromel, Co, Cr, Cu, Cu/Ag, Ge, Fe, Ni, NiCr, NiCrFe, Nb, Si (p-type), Ta, Ti, TiW, V, W, Cr<sub>2</sub>Si, Zr, Hf

*Oxides / Ceramics:* Al<sub>2</sub>O<sub>3</sub>, AlN, SiO<sub>2</sub>, IrO<sub>x</sub>, ITO, BN, YSZ

*Evaporation:* Al, Ag, Au, Au/Ge, Cr, Cu, Mo, NiCr, Ni, Ta, Ti

- ♦ Denton e-beam DV-SJ/20C with four hearths

*PECVD*

- ♦ **New!** Oxford PlasmaPro 100 Cobra 300 ICP: Si<sub>3</sub>N<sub>4</sub>, SiO<sub>2</sub>, amorphous Si, coats pieces up to 200mm wafers

*CVD*

- ♦ SCS PDS 2010 Parylene-C

*MOCVD*

- ♦ Agnition Agilis-IH: Gallium Oxide, Germanium Oxide

*ALD*

- ♦ Cambridge Fiji F200 w/ thermal & plasma dep modes, H<sub>2</sub>O plasma (Pt, HfO<sub>2</sub>, ZnO, Al<sub>2</sub>O<sub>3</sub>, SiO<sub>2</sub>, TiO<sub>2</sub>, ZrO<sub>2</sub>)

## FURNACES and DIFFUSION (Class 1000)

*LPCVD*

- ♦ Expertech TEOS / LTO / PSG / low-stress, silicon-rich and stoichiometric Si<sub>3</sub>N<sub>4</sub>, α & P-doped polysilicon

*Atmospheric and Rapid Annealing*

- ♦ Allwin 610 RTP/RTA with O<sub>2</sub>, N<sub>2</sub>, Ar, H<sub>2</sub> forming gas, 200-1250°C. Pieces to 150mm wafers.
- ♦ ProTemp wet/dry thermal silicon oxidation with DCE
- ♦ Blue-M box furnace with N<sub>2</sub> or Ar purge (1100 °C)
- ♦ Vacuum oven (250 °C)

## ETCH (Class 1000)

*RIE and DRIE*

- ♦ Oxford Plasmalab 100+ ICP DRIE Bosch & cryo, SF<sub>6</sub>, CF<sub>4</sub>, CHF<sub>3</sub>, O<sub>2</sub>, Ar, N<sub>2</sub>
- ♦ **New!** Oxford PlasmaPro 100 Cobra 300 ICP DRIE: etches pieces up to 200mm wafers
- ♦ Technics PEII H<sub>2</sub>O vapor, O<sub>2</sub> descum & resist strip
- ♦ Xactix Xetch XeF<sub>2</sub> silicon isotropic dry etch
- ♦ Plasmatherm 790 metal RIE (Cl<sub>2</sub>, BCl<sub>3</sub>, SF<sub>6</sub>, CF<sub>4</sub>, O<sub>2</sub>, Ar)

*Wet Chemical*

- ♦ Wet benches & SRDs (x7) acids, bases, develop
- ♦ Solvent hoods (x8): liftoff lithography, strip, clean

- ♦ Gold wet-etch station

## MICROMACHINING / MESO-SCALE PROTOTYPING

- ♦ KOH bulk Si micromachining etch station
- ♦ ULS CO<sub>2</sub> flatbed laser (25W + 75W, 1090nm)
- ♦ DPSS Samurai UV laser (355nm, 10um spot size, 3 W)

## PACKAGING, ASSEMBLY, and BACKEND PROCESSES

- ♦ EVG 520IS wafer bonder (anodic, eutectic, polymer, fusion)
- ♦ Disco DAD 641 & Disco 3220 dicing saws (std or UV tape)
- ♦ MEI wedge wirebonder with Au and Al wire
- ♦ LPKF S104 PCB milling system
- ♦ LPKF Contac S4 PCB through-hole plating system
- ♦ LPKF Protoflow S4 solder reflow oven
- ♦ CHM-550 SMT Pick and place machine

## CLEAN (Class 10,000) MICROFLUIDICS

- ♦ SU-8 soft lithography and Sylgard 184 PDMS bonding
- ♦ Corona discharge UV/O<sub>3</sub> plasma treatment

## CLEANROOM (Class 1000) METROLOGY AND TESTING

- ♦ Keyence VHX-5000 & VHX1 3D measuring microscopes
- ♦ n&k NKT 1500 thin film analyzer with wafer mapping
- ♦ Nanometrics NanoSpec 3000 film thickness
- ♦ Filmetrics F20 & F40 small spot film thickness
- ♦ Magnetron Instruments 4-point probe
- ♦ Polyvar Met with DIC + many optical microscopes
- ♦ Tencor P-10, P-20, & Alphascan D600 stylus profilometers
- ♦ Tencor Flexus 2320 film stress analyzer
- ♦ Verigy 9300 SOC IC tester
- ♦ Keithley 4200A semiconductor parameter analyzer (four SMUs + Micromanipulator probe station)

## CLEANROOM STAFF SERVICES

- ♦ Sign up to use the Nanofab:  
<https://www.nanofab.utah.edu/get-access-to-our-lab/>
- ♦ Professional technical support
  - 3D microprinting on Nanoscribe GT2 Pro
  - Photomask design and generation
  - Wafer/chip design and fabrication (up to 200mm)
    - ♦ Microfluidics
    - ♦ Microoptics (lenses, diffractive optical elements)
    - ♦ MEMS and microactuators
    - ♦ Microsensors and Multi-electrode arrays
- ♦ Thin film deposition, lithography, and patterning